Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | BARKAN ET AL. | Examiner | Art Unit | Seung H. Lee | 2876 | Page 1 of 1

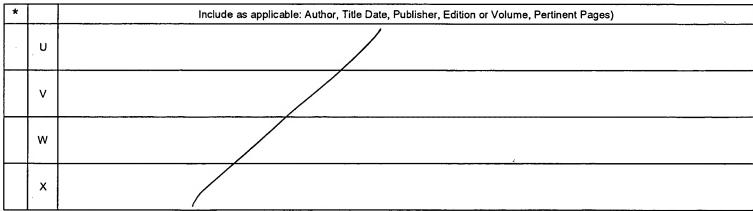
U.S. PATENT DOCUMENTS

		Dearment Number	Data		1
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,786,413	09-2004	Gurevich et al.	235/462.4
	В	US-6,045,046	04-2000	Detwiler, Paul O.	235/114
	С	US-6,543,694	04-2003	Detwiler, Paul O.	235/462.4
	D	US-		/	
	Е	US-			
	Ľ.	US-			
	O	US-			
	Ξ	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-		/	
	М	US-		j	

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z			/		
	0					
	Ρ					
	ď					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS



*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.